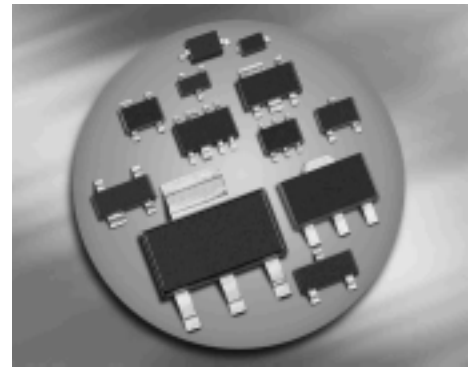


**Silicon N-Channel MOSFET Tetrode**

- For low noise , high gain controlled input stages up to 1GHz
- Operating voltage 5 V
- Pb-free (RoHS compliant) package
- Qualified according AEC Q101



**ESD (Electrostatic discharge) sensitive device, observe handling precaution!**

| Type    | Package | Pin Configuration |     |      |      |   |   | Marking |
|---------|---------|-------------------|-----|------|------|---|---|---------|
| BF2040  | SOT143  | 1=S               | 2=D | 3=G2 | 4=G1 | - | - | NFs     |
| BF2040R | SOT143R | 1=D               | 2=S | 3=G1 | 4=G2 | - | - | NFs     |
| BF2040W | SOT343  | 1=D               | 2=S | 3=G1 | 4=G2 | - | - | NFs     |

**Maximum Ratings**

| Parameter                                                                                                         | Symbol           | Value       | Unit             |
|-------------------------------------------------------------------------------------------------------------------|------------------|-------------|------------------|
| Drain-source voltage                                                                                              | $V_{DS}$         | 8           | V                |
| Continuous drain current                                                                                          | $I_D$            | 40          | mA               |
| Gate 1/ gate 2-source current                                                                                     | $\pm I_{G1/2SM}$ | 10          |                  |
| Gate 1 (external biasing)                                                                                         | $+V_{G1SE}$      | 7           | V                |
| Total power dissipation<br>$T_S \leq 76^\circ\text{C}$ , BF2040, BF2040R<br>$T_S \leq 94^\circ\text{C}$ , BF2040W | $P_{tot}$        | 200<br>200  | mW               |
| Storage temperature                                                                                               | $T_{stg}$        | -55 ... 150 | $^\circ\text{C}$ |
| Channel temperature                                                                                               | $T_{ch}$         | 150         |                  |

**Thermal Resistance**

| Parameter                                                             | Symbol      | Value                    | Unit |
|-----------------------------------------------------------------------|-------------|--------------------------|------|
| Channel - soldering point <sup>1)</sup><br>BF2040, BF2040R<br>BF2040W | $R_{thchs}$ | $\leq 370$<br>$\leq 280$ | K/W  |

<sup>1)</sup>For calculation of  $R_{thJA}$  please refer to Application Note Thermal Resistance

**Electrical Characteristics** at  $T_A = 25^\circ\text{C}$ , unless otherwise specified

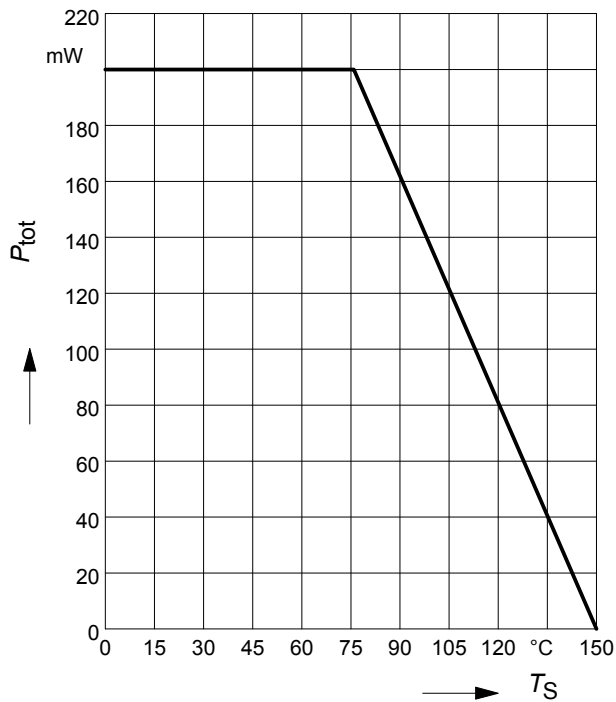
| Parameter                                                                                                               | Symbol                        | Values |      |      | Unit          |
|-------------------------------------------------------------------------------------------------------------------------|-------------------------------|--------|------|------|---------------|
|                                                                                                                         |                               | min.   | typ. | max. |               |
| DC Characteristics                                                                                                      |                               |        |      |      |               |
| Drain-source breakdown voltage<br>$I_D = 20\ \mu\text{A}$ , $V_{G1S} = 0$ , $V_{G2S} = 0$                               | $V_{(\text{BR})\text{DS}}$    | 10     | -    | -    | V             |
| Gate1-source breakdown voltage<br>$+I_{G1S} = 10\ \text{mA}$ , $V_{G2S} = 0$ , $V_{\text{DS}} = 0$                      | $+V_{(\text{BR})\text{G1SS}}$ | 6      | -    | 15   |               |
| Gate2-source breakdown voltage<br>$+I_{G2S} = 10\ \text{mA}$ , $V_{G1S} = 0$ , $V_{\text{DS}} = 0$                      | $+V_{(\text{BR})\text{G2SS}}$ | 6      | -    | 15   |               |
| Gate1-source leakage current<br>$V_{G1S} = 5\ \text{V}$ , $V_{G2S} = 0$ , $V_{\text{DS}} = 0$                           | $+I_{\text{G1SS}}$            | -      | -    | 50   | nA            |
| Gate2-source leakage current<br>$V_{G2S} = 5\ \text{V}$ , $V_{G1S} = 0$ , $V_{\text{DS}} = 0$                           | $+I_{\text{G2SS}}$            | -      | -    | 50   |               |
| Drain current<br>$V_{\text{DS}} = 5\ \text{V}$ , $V_{G1S} = 0$ , $V_{G2S} = 4\ \text{V}$                                | $I_{\text{DSS}}$              | -      | -    | 50   | $\mu\text{A}$ |
| Drain-source current<br>$V_{\text{DS}} = 5\ \text{V}$ , $V_{G2S} = 4\ \text{V}$ , $R_{\text{G1}} = 100\ \text{k}\Omega$ | $I_{\text{DSX}}$              | -      | 15   | -    | mA            |
| Gate1-source pinch-off voltage<br>$V_{\text{DS}} = 5\ \text{V}$ , $V_{G2S} = 4\ \text{V}$ , $I_D = 20\ \mu\text{A}$     | $V_{\text{G1S(p)}}$           | 0.3    | 0.6  | -    | V             |
| Gate2-source pinch-off voltage<br>$V_{\text{DS}} = 5\ \text{V}$ , $I_D = 20\ \mu\text{A}$                               | $V_{\text{G2S(p)}}$           | 0.3    | 0.7  | -    |               |

**Electrical Characteristics** at  $T_A = 25^\circ\text{C}$ , unless otherwise specified

| Parameter                                                                                                                 | Symbol       | Values |      |      | Unit |
|---------------------------------------------------------------------------------------------------------------------------|--------------|--------|------|------|------|
|                                                                                                                           |              | min.   | typ. | max. |      |
| AC Characteristics - (verified by random sampling)                                                                        |              |        |      |      |      |
| Forward transconductance<br>$V_{DS} = 5\text{ V}$ , $I_D = 15\text{ mA}$ , $V_{G2S} = 4\text{ V}$                         | $g_{fs}$     | 37     | 42   | -    | mS   |
| Gate1 input capacitance<br>$V_{DS} = 5\text{ V}$ , $I_D = 15\text{ mA}$ , $V_{G2S} = 4\text{ V}$ ,<br>$f = 10\text{ MHz}$ | $C_{g1ss}$   | -      | 2.9  | 3.4  | pF   |
| Output capacitance<br>$V_{DS} = 5\text{ V}$ , $I_D = 15\text{ mA}$ , $V_{G2S} = 4\text{ V}$ ,<br>$f = 10\text{ MHz}$      | $C_{dss}$    | -      | 1.6  | -    |      |
| Power gain<br>$V_{DS} = 5\text{ V}$ , $I_D = 15\text{ mA}$ , $V_{G2S} = 4\text{ V}$ ,<br>$f = 800\text{ MHz}$             | $G_p$        | 20     | 23   | -    | dB   |
| Noise figure<br>$V_{DS} = 5\text{ V}$ , $I_D = 15\text{ mA}$ , $V_{G2S} = 4\text{ V}$ ,<br>$f = 800\text{ MHz}$           | $F$          | -      | 1.6  | 2.2  | dB   |
| Gain control range<br>$V_{DS} = 5\text{ V}$ , $V_{G2S} = 4 \dots 0\text{ V}$ , $f = 800\text{ GHz}$                       | $\Delta G_p$ | 45     | 50   | -    |      |

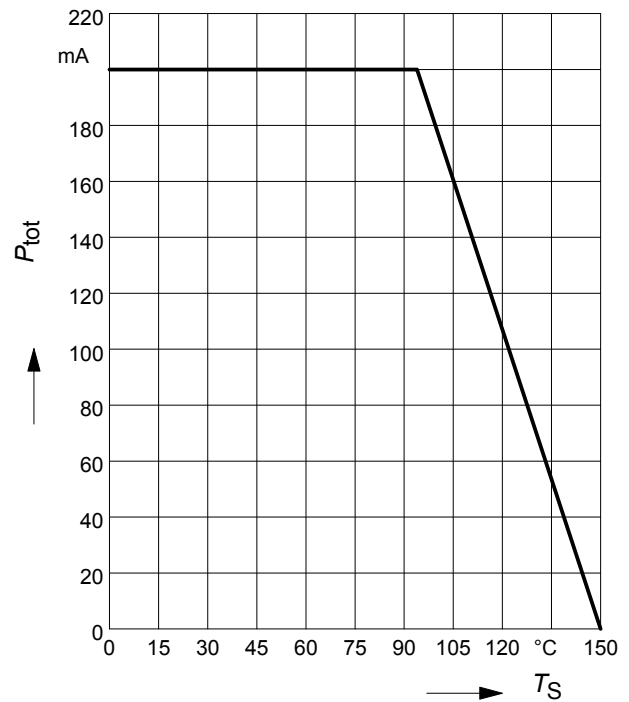
**Total power dissipation  $P_{\text{tot}} = f(T_S)$**

BF2040, BFD2040R



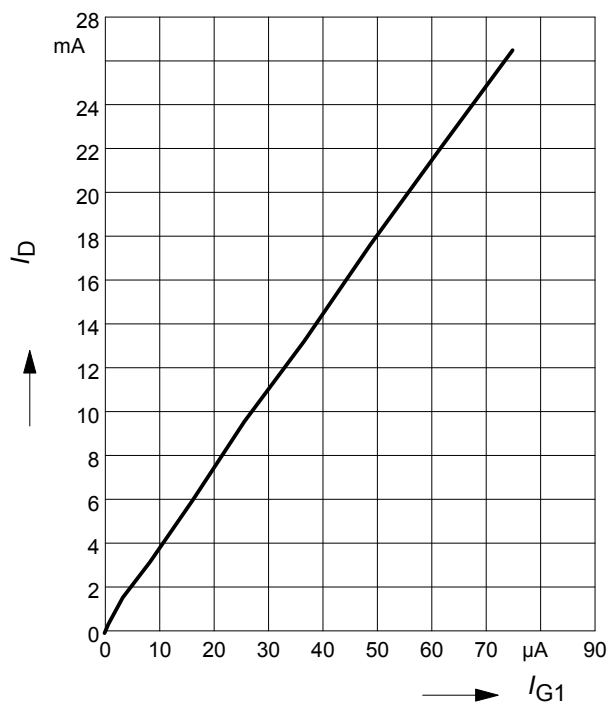
**Total power dissipation  $P_{\text{tot}} = f(T_S)$**

BF2040W



**Drain current  $I_D = f(I_{G1})$**

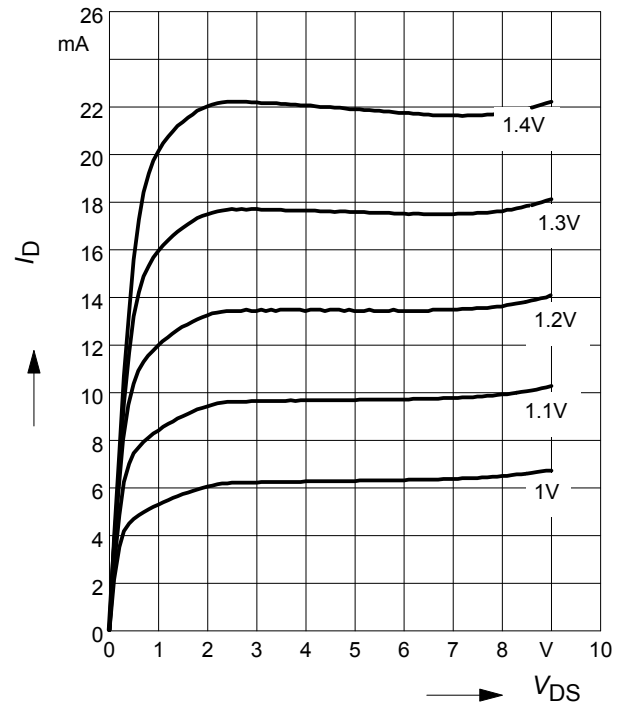
$V_{G2S} = 4V$



**Output characteristics  $I_D = f(V_{DS})$**

$V_{G2S} = 4V$

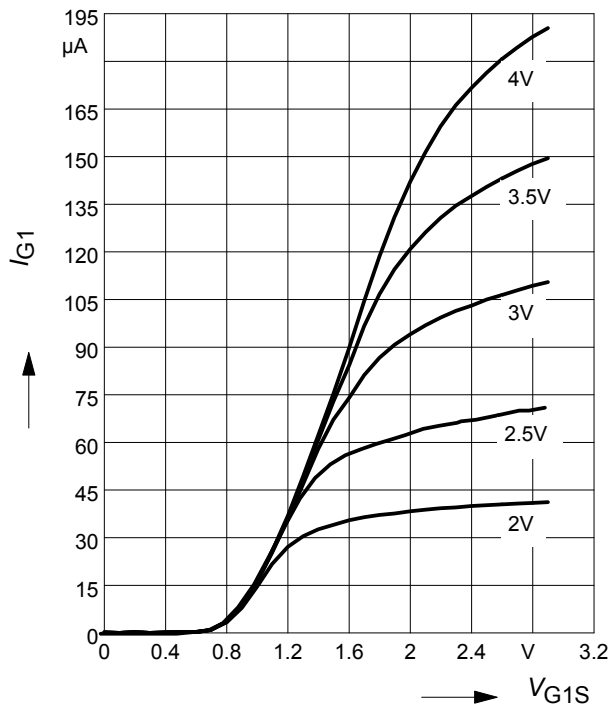
$V_{G1S} = \text{Parameter}$



### Gate 1 current $I_{G1} = f(V_{G1S})$

$V_{DS} = 5V$

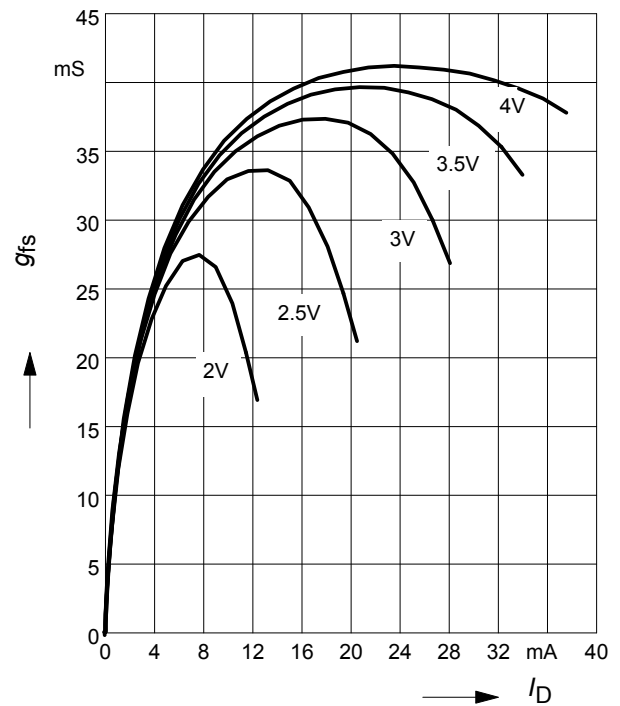
$V_{G2S} = \text{Parameter}$



### Gate 1 forward transconductance

$g_{fs} = f(I_D)$

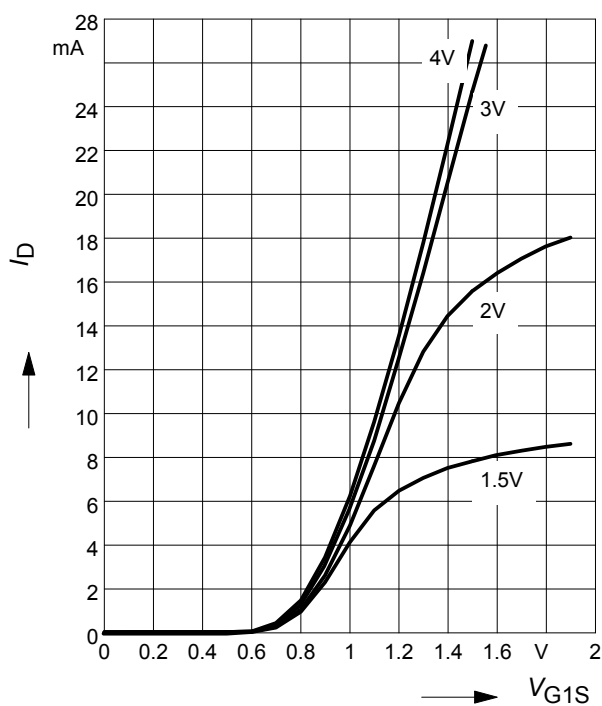
$V_{DS} = 5V, V_{G2S} = \text{Parameter}$



### Drain current $I_D = f(V_{G1S})$

$V_{DS} = 5V$

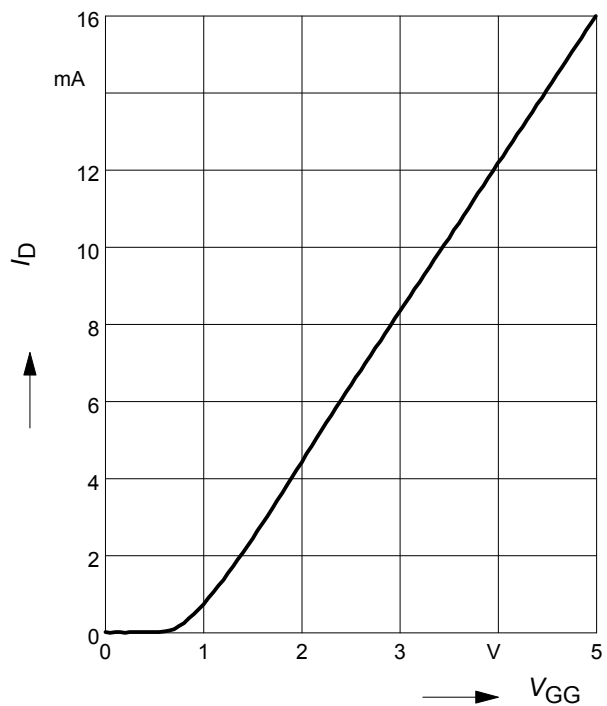
$V_{G2S} = \text{Parameter}$



### Drain current $I_D = f(V_{GG})$

$V_{DS} = 5V, V_{G2S} = 4V, R_{G1} = 80k\Omega$

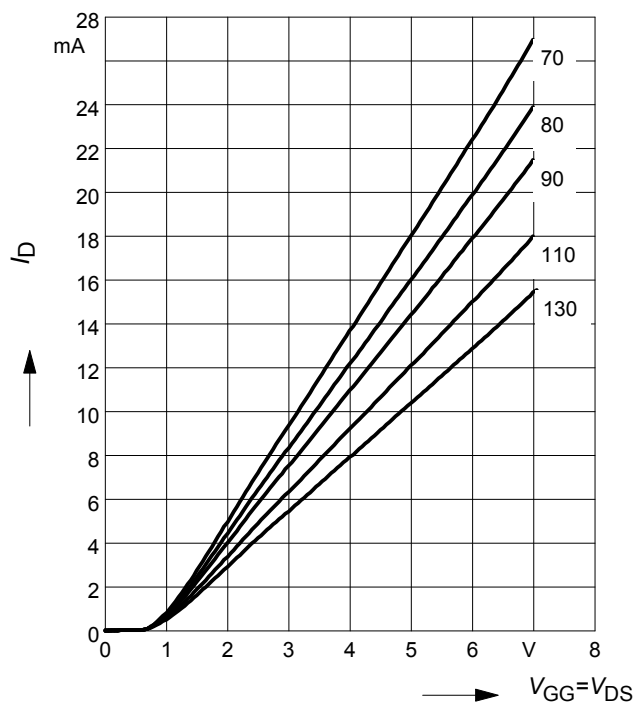
(connected to  $V_{GG}$ ,  $V_{GG} = \text{gate1 supply voltage}$ )



**Drain current  $I_D = f(V_{GG})$**

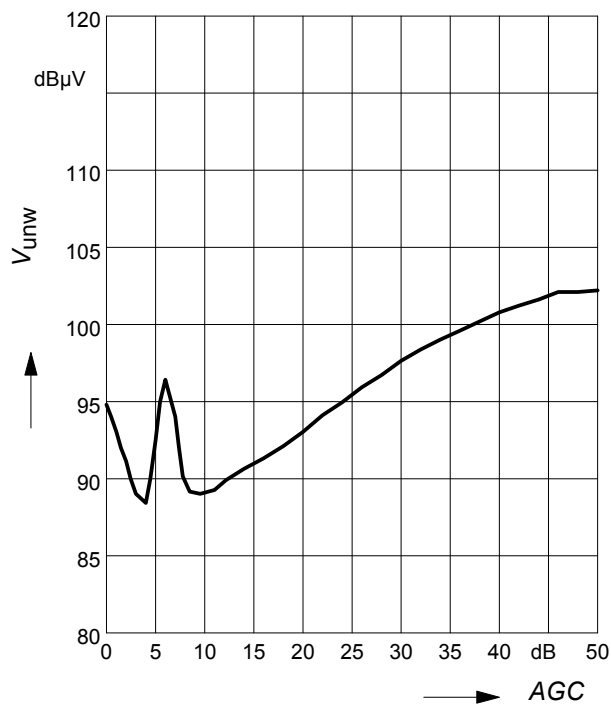
$V_{G2S} = 4V$

$R_{G1}$  = Parameter in  $k\Omega$

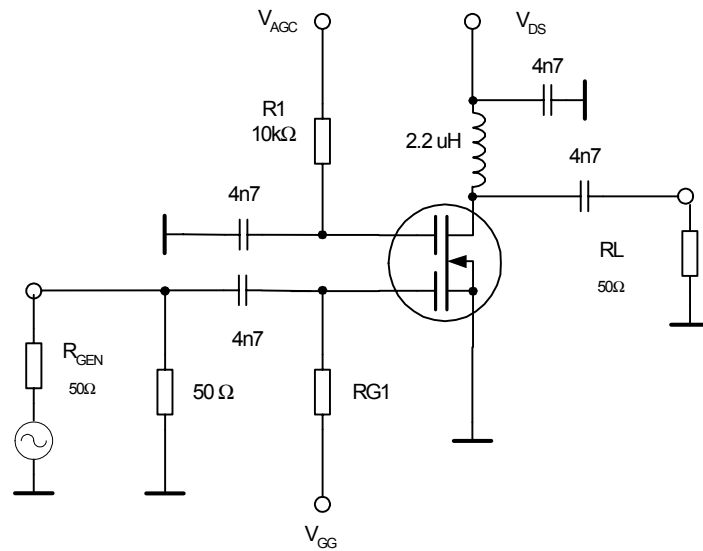


**Crossmodulation  $V_{unw} = (AGC)$**

$V_{DS} = 5V$

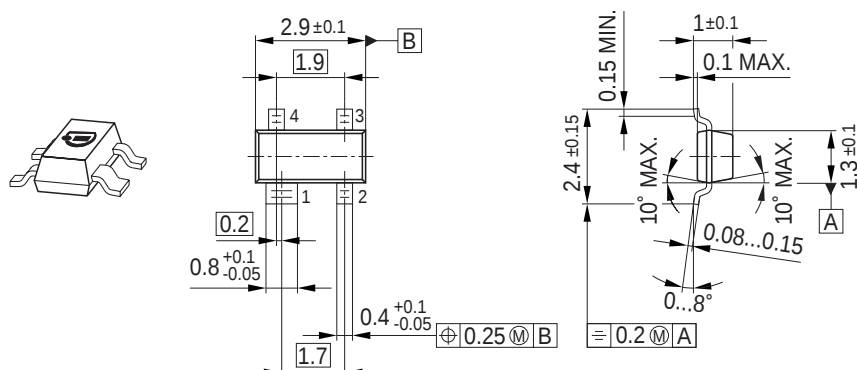


## Cossmodulation test circuit

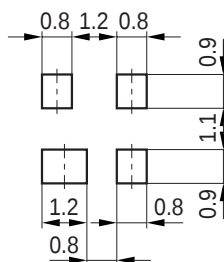


Semibiased

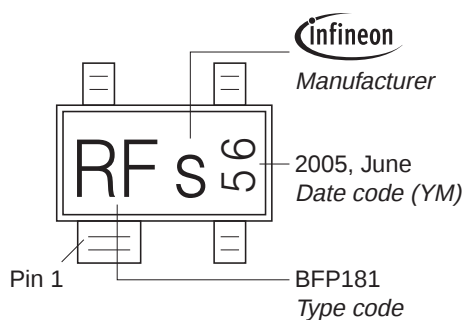
## Package Outline



## Foot Print

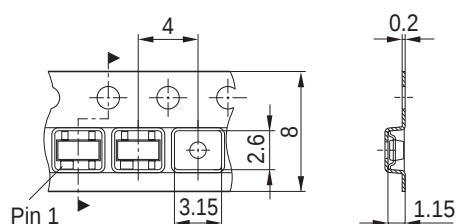


## Marking Layout (Example)

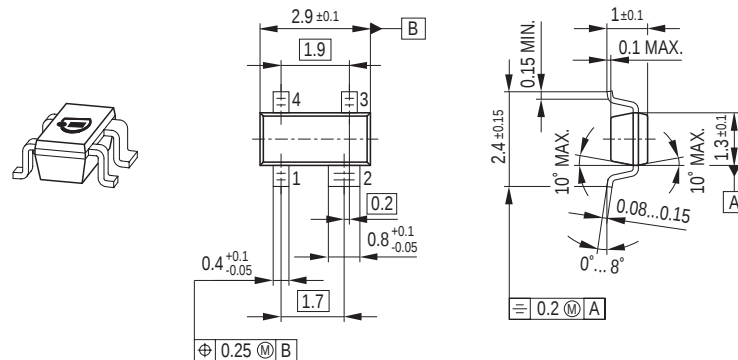


## Standard Packing

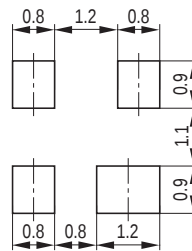
Reel  $\varnothing 180$  mm = 3.000 Pieces/Reel  
 Reel  $\varnothing 330$  mm = 10.000 Pieces/Reel



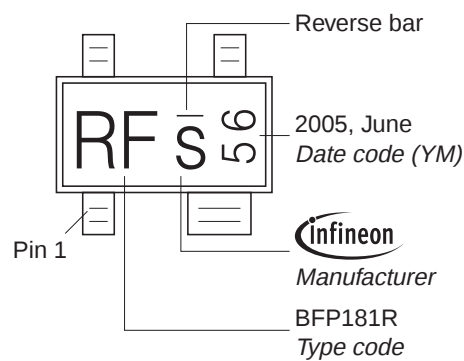
## Package Outline



## Foot Print

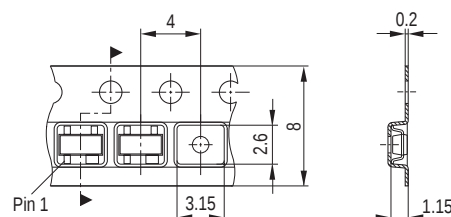


## Marking Layout (Example)

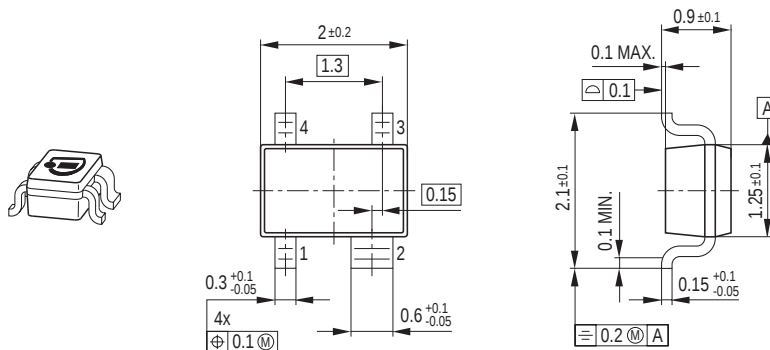


## Standard Packing

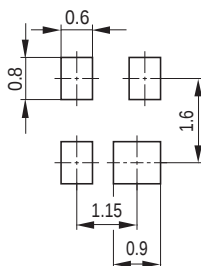
Reel ø180 mm = 3.000 Pieces/Reel  
Reel ø330 mm = 10.000 Pieces/Reel



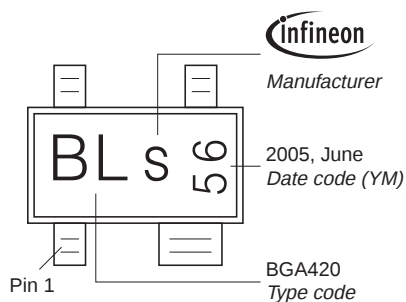
## Package Outline



## Foot Print

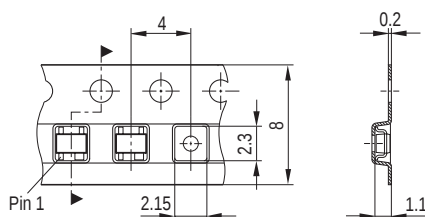


## Marking Layout (Example)



## Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel  
Reel ø330 mm = 10.000 Pieces/Reel



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